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| Subst. Form PTO-1449 APPLICANT'S INFORMATION DISCLOSURE STATEMENT | | Atty. Docket No.: RPS920010172091 (IRA-10-5709) | Serial No.: To be assigned |
| | | Applicant: Atoji et al | |
| | | Filing Date: Herewith | Group: To-be-assigned 2193 |

U.S. PATENT DOCUMENTS

| Initial* | | Document No. | Date | Name | Class | Subcl. | Filing Date |
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| MPF | AL | JP2001051965A | 08/12/1999 | Japan | — | — | No |
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| MPF | AU | "Automatic Test Program Generation for Pipelined Processors", IEEE/ACM International Conference on CAD-94, November 6-10, 1994, pgs. 580-583 |

Examiner: Mark P. Francis Date Considered: 7/6/06

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if in conformance and not considered.
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